imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



| ALPHA & OMEGA SEMICONDUCTOR | | | AOL1242 40V N-Channel MOSFE | | | |
|---|---|-----------------------------------|---|-----|----------------------------------|--|
| General Descri | ption | | Product Summa | ary | | |
| The AOL1242 uses trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Power losses are minimized due to an extremely low combination of $R_{DS(ON)}$ and Crss.In addition, switching behavior is well controlled with a "Schottky style" soft recovery body diode. | | | V_{DS} $I_{D} (at V_{GS}=10V)$ $R_{DS(ON)} (at V_{GS}=10V)$ $R_{DS(ON)} (at V_{GS}=4.5V)$ 100% UIS Tested 100% R _g Tested | | 40V 69A < 5.2mΩ < 7.9mΩ | |
| Absolute Maximum | UltraSO-8 TM Top View Bott | tom View | | | | |
| Parameter | | Symbol | Maxim | um | Units | |
| Drain-Source Voltage |) | V _{DS} | 40 | 40 | | |
| Gate-Source Voltage | | V _{GS} | ±20 | | V | |
| Continuous Drain Current ^G | T _C =25℃ T _C =100℃ | I _D | 69 54 | | A | |
| Pulsed Drain Current | | I _{DM} | 205 | | | |
| Continuous Drain Current | T _A =25℃ T _A =70℃ | I _{DSM} | 14 | | - A | |
| Avalanche Current ^C | + | I _{AS} , I _{AR} | 40 | | A | |
| Avalanche energy L=0.1mH ^C | | E _{AS} , E _{AR} | 80 | | mJ | |
| 37 - | T _c =25℃ | | 68 34 2.1 | | | |
| Power Dissipation ^B | T _C =100℃ | P _D | | | - W | |
| end Biosipation | T _A =25°C | | | | W | |
| Power Dissipation ^A | T _A =70℃ | P _{DSM} 2.1 | | | | |
| Junction and Storage Temperature Range | | | -55 to 175 | | ~ | |
| unction and Storage | remperature Range | T_J,T_STG | -55 [0 | 170 | Ĵ | |
| Thermal Characteris | stics | | | | | |
| Parameter | | Symbol | Тур | Max | Units | |
| Maximum Junction-to | -Ambient ^A t<10s | | 20 | 25 | 90/M | |

| Thermal Characteristics | | | | | | | |
|--|--------------|------------------|-----|-------|------|--|--|
| Parameter | Symbol | Тур | Max | Units | | | |
| Maximum Junction-to-Ambient ^A | t ≤ 10s | D | 20 | 25 | °C/W | | |
| Maximum Junction-to-Ambient AD | Steady-State | R _{0JA} | 50 | 60 | °C/W | | |
| Maximum Junction-to-Case | Steady-State | $R_{\theta JC}$ | 1.8 | 2.2 | °C/W | | |



Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | | Min | Тур | Max | Units |
|--|---|--|----------------------|------|------|------|-------|
| STATIC F | PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | I _D =250μA, V _{GS} =0V | | 40 | | | V |
| I _{DSS} Zero Gate Voltage Drain Current | V_{DS} =40V, V_{GS} =0V | | | | 1 | | |
| | Zero Gate Voltage Drain Current | T _J =55℃ | | | | 5 | μA |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} =±20V | | | | 100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS}=V_{GS}$, $I_{D}=250\mu A$ | | 1.3 | 1.8 | 2.3 | V |
| I _{D(ON)} | On state drain current | V_{GS} =10V, V_{DS} =5V | | 205 | | | Α |
| | Static Drain-Source On-Resistance | V_{GS} =10V, I_{D} =20A | | | 4.2 | 5.2 | mΩ |
| | | | T _J =125℃ | | 6.9 | 8.5 | |
| | | V_{GS} =4.5V, I_{D} =20A | | | 6.1 | 7.9 | mΩ |
| g _{FS} | Forward Transconductance | $V_{DS}=5V, I_{D}=20A$ | | | 70 | | S |
| V_{SD} | Diode Forward Voltage | I _S =1A,V _{GS} =0V | | | 0.7 | 1 | V |
| I _s | Maximum Body-Diode Continuous Current G | | | | | 69 | А |
| DYNAMIC | C PARAMETERS | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =20V, f=1MHz | | 1080 | 1350 | 1620 | pF |
| C _{oss} | Output Capacitance | | | 280 | 405 | 530 | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 7 | 26 | 45 | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | | 1 | 2 | 3 | Ω |
| SWITCHI | NG PARAMETERS | | | | | | |
| Q _g (10V) | Total Gate Charge | | | 15 | 19 | 23 | nC |
| Q _g (4.5V) | Total Gate Charge | | _20.4 | 5 | 8 | 11 | nC |
| Q _{gs} | Gate Source Charge | V_{GS} =10V, V_{DS} =20V, I_{D} =20A | | | 4.5 | | nC |
| Q_{gd} | Gate Drain Charge | | | | 2.3 | | nC |
| t _{D(on)} | Turn-On DelayTime | | | | 6 | | ns |
| t _r | Turn-On Rise Time | V_{GS} =10V, V_{DS} =20V, R_{L} =1 Ω , R_{GEN} =3 Ω | | | 2.5 | | ns |
| t _{D(off)} | Turn-Off DelayTime | | | | 23 | | ns |
| t _f | Turn-Off Fall Time | | | | 4 | | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =20A, dI/dt=500A/μs | | 10 | 15.5 | 21 | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =20A, dI/dt=500A/μs | | 21 | 31 | 41 | nC |

A. The value of R_{6JA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R_{0JA} and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation P_D is based on $T_{J(MAX)}=175^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175° C. Ratings are based on low frequency and duty cycles to keep initial $T_{J} = 25^{\circ}$ C.

D. The R_{BJA} is the sum of the thermal impedance from junction to case R_{BJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.

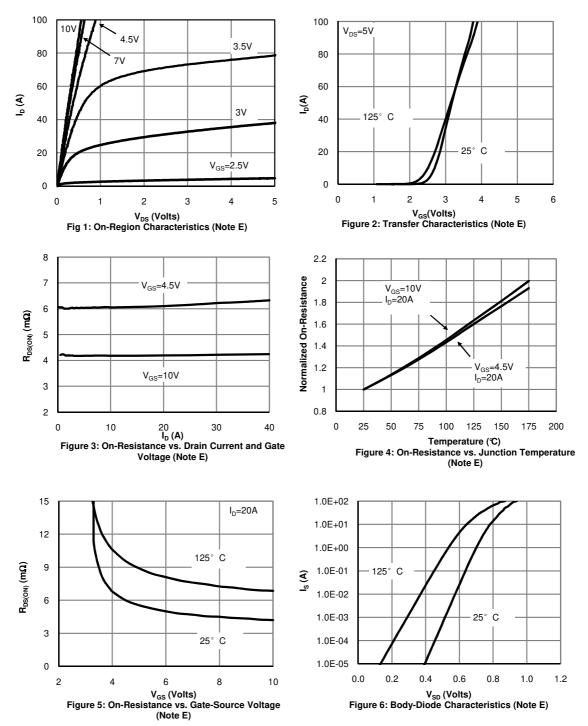
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

THIS PRODUCT HAS BEEN DESIGNED AND QUALIFIED FOR THE CONSUMER MARKET. APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS







TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

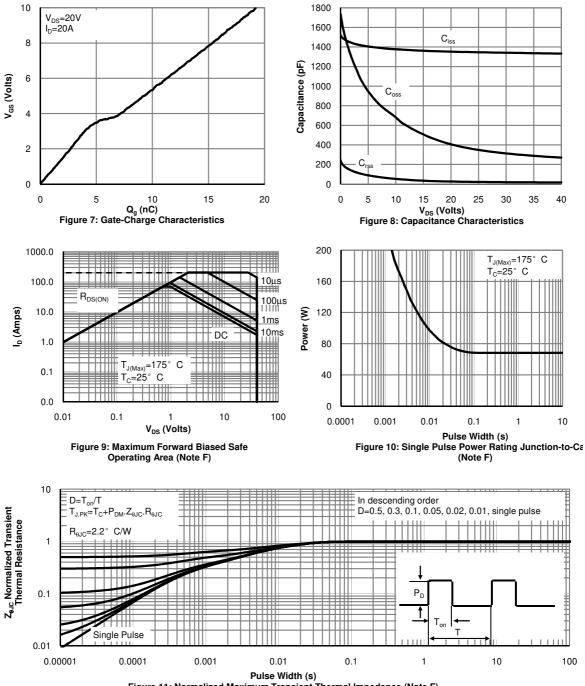
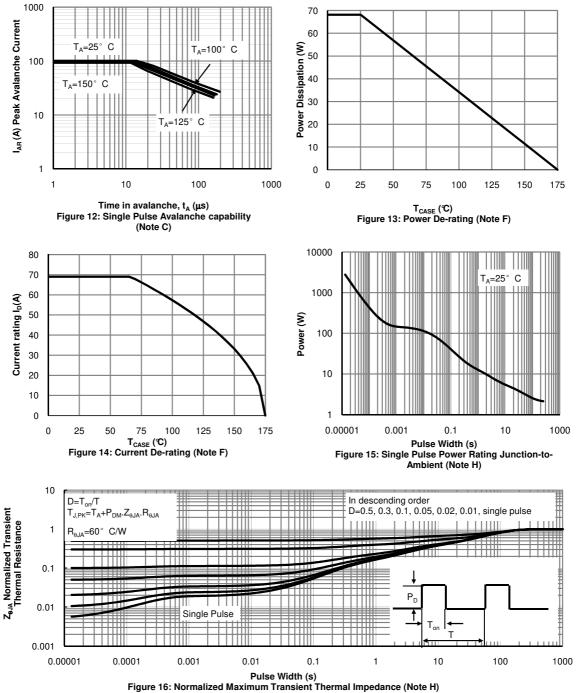


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

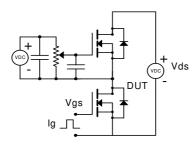


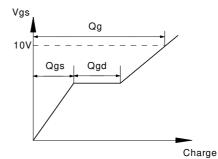
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



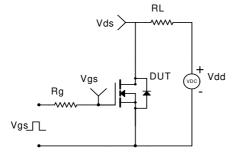


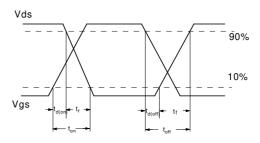
Gate Charge Test Circuit & Waveform



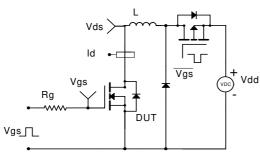


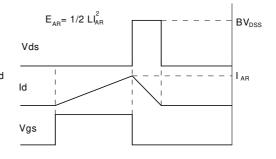
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

